U.S. Patent Documents

Examiner Initial	Cited In Parent	DOCUMENT NUMBER	DATE	Name	CLASS	SUBC LASS	FILING DATE
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EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant

X = Filed by Applicant in Parent

XX = Cited by Examiner in Parent

PTO1449

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